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Machine Learning (ML) and Software Engineering, Volume II

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Message from the Guest Editors

Dear Colleagues,

Specific topics of interest include, but are not limited to, the following:

- Artificial intelligence for software engineering;
- Software engineering for artificial intelligence:
- Machine learning for requirement engineering;
- Machine learning for design;
- Machine learning for code generation;
- Machine learning for code example generation;
- Machine learning for code description;
- Machine learning for testing;
- Machine learning for code changes;
- Machine learning for artifact changes;
- CI, DevOps, and MLOps for intelligent software systems;
- Issues on autonomous vehicles;
- Issues on autonomous flights;
- Issues on medical Als.











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Message from the Editor-in-Chief

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